Application/Control No. 10/022,263 Examiner Daniel I Walsh Applicant(s)/Patent Under Reexamination ONO ET AL. Art Unit 2876 Page 1 of 1

Notice of References Cited

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-5,850,077	12-1998	Tognazzini, Bruce	235/380
	В	US-6,149,058	11-2000	Albaret, Thierry	235/380
	С	US-6,168,078	01-2001	Yanagi et al.	235/380
	D	US-6,189,782	02-2001	Takami et al.	235/375
	Ε	US-5,945,652	08-1999	Ohki et al.	235/380
	F	US-6,003,008	12-1999	Postrel et al.	235/381
	G	US-6,047,888	04-2000	Dethloff, Juergen	235/375
	Н	US-6,016,957	01-2000	Ohki et al.	235/380
	ı	US-5,949,047	09-1999	Abe et al.	235/435
	J	US-6,358,188	03-2002	Ben-Yehuda et al.	482/8
	к	US-6,268,879	07-2001	Sato, Yoshiaki	348/14.01
	L	US-5,965,860	10-1999	Oneda, Hideo	235/375
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 11227369 A	08-1999	Japan		B42D 15/10
	0					
	Р					
	Q					
	R					
	s					
	Т					

NON-PATENT DOCUMENTS

	ROW ATEN BOOMENTO							
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)						
	U							
	٧							
	w							
	х							

"A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.